What does "normal-normal transmittance" mean for light-scattering materials?



Helen Rose Wilson¹, Bruno Bueno¹, Johannes Hanek¹, Christoph Riethmüller², Holger Illg², Bertrand Deroisy³, Tilmann E. Kuhn¹

 1: Fraunhofer Institute for
Solar Energy Systems ISE
2: Deutsche Institute f
 ür Textilund Faserforschung
3: Belgian Building Research Institute



Contents

- Motivation
- Definitions
- Determining τ_{v,n-n} by measurement, concentrating on integrating spheres
- Characteristics of investigated solar-shading textiles
- Results for "critical" textile samples with regard to $\tau_{v,n-n}$
- Pullback method for improved agreement in τ_{v.n-n}
- Outlook further applications

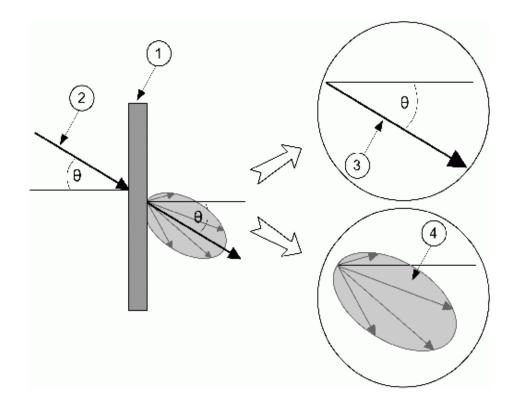


Motivation

- Question: What does "normal-normal transmittance" mean for light-scattering materials?
- Answer (from EN 14500:2008): Fraction of normally incident radiation flux that is transmitted in accordance with the laws of geometrical optics, without diffusion or redirection
- Normal-normal transmittance is an input for performance metrics characterising solar-shading materials and glazing with respect to
 - Glare control
 - Protection against direct solar radiation
 - Night privacy
 - Visual contact with the outdoor environment



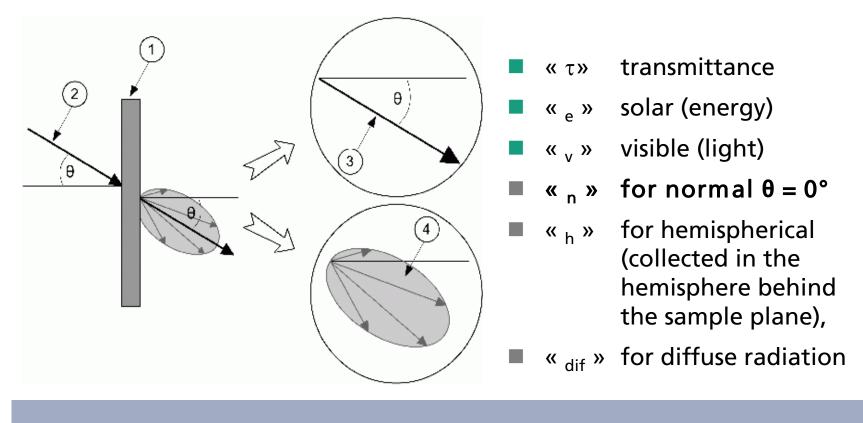
Nomenclature referring to transmittance from EN 14500



- 1. Solar-shading material
- 2. Incident directional radiation
- 3. Transmitted direct component radiation
- 4. Transmitted diffuse component radiation



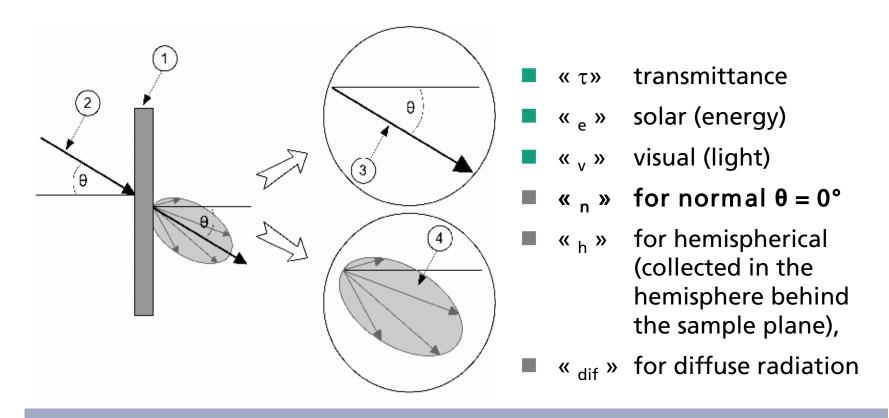
Nomenclature referring to transmittance from EN 14500



$$\tau_{v, n-n} = \tau_{v, n-h} - \tau_{v, n-dif}$$

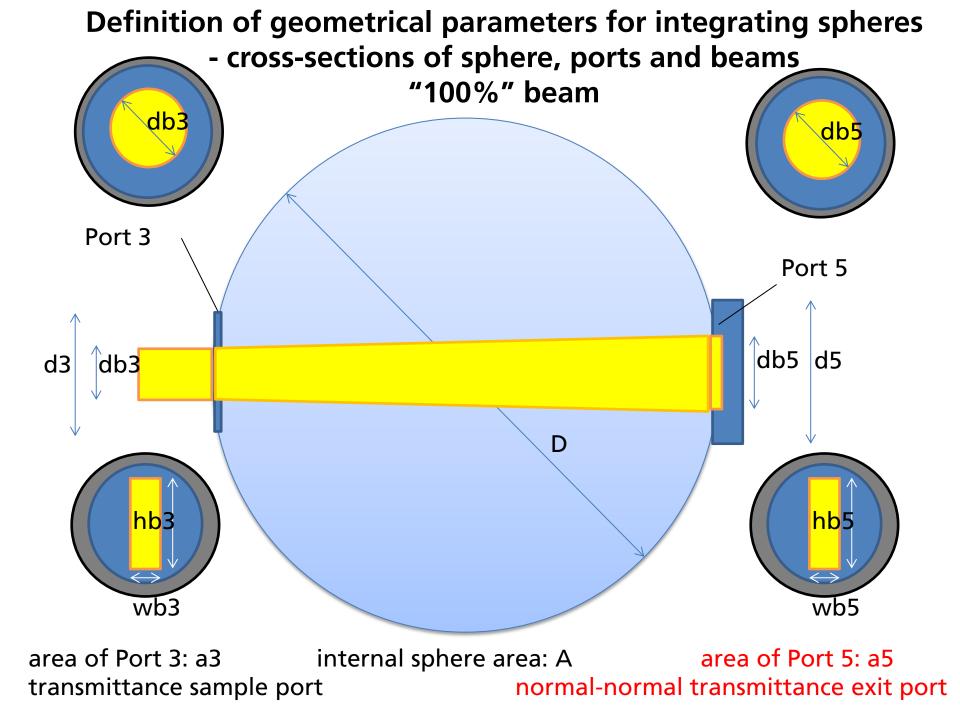


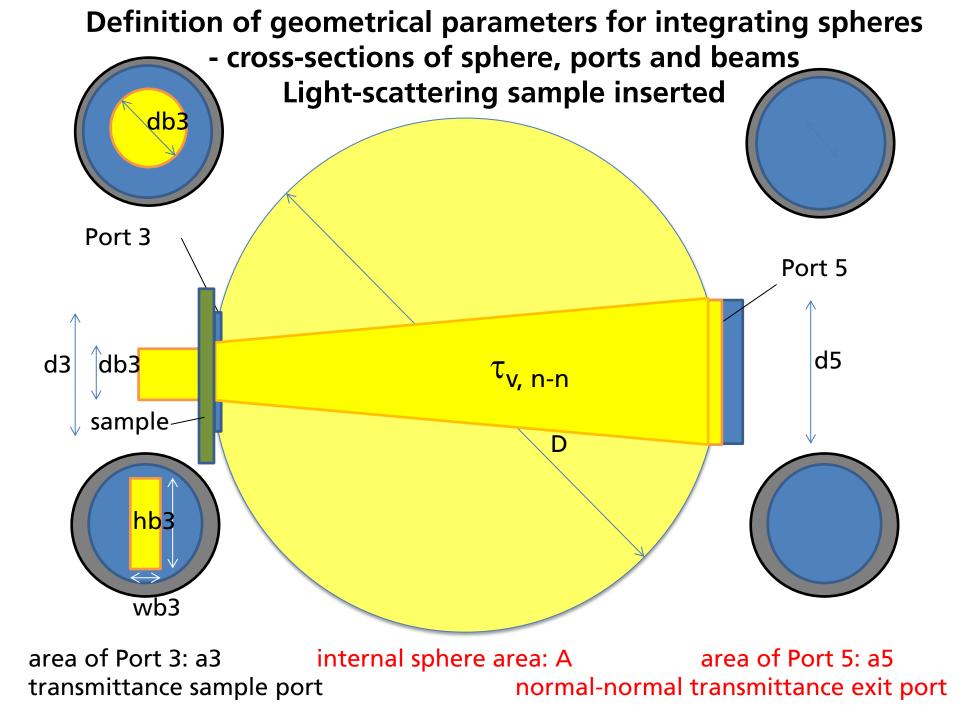
Measurement methods to determine $\tau_{v, n-n}$



1. Integrating Sphere: $\tau_{v, n-n} = \tau_{v, n-h} - \tau_{v, n-dif}$ 2. Direct measurement of $\tau_{v, n-n}$: (see EN 14500:2018)





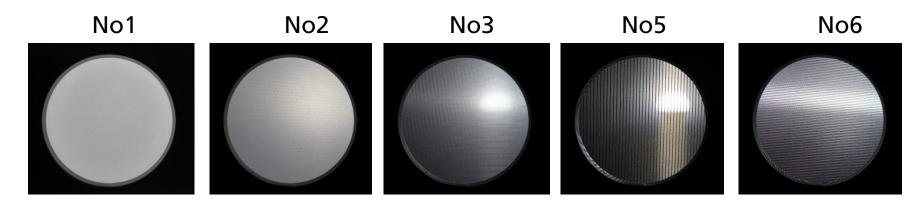


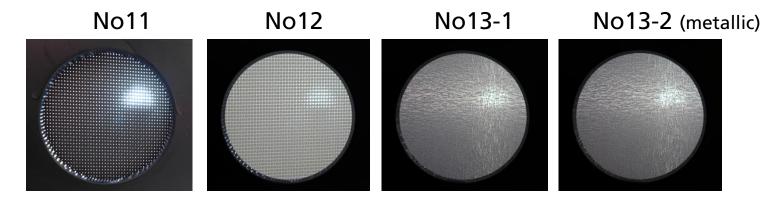
Investigated solar-shading textiles

- Transmitted images of light source







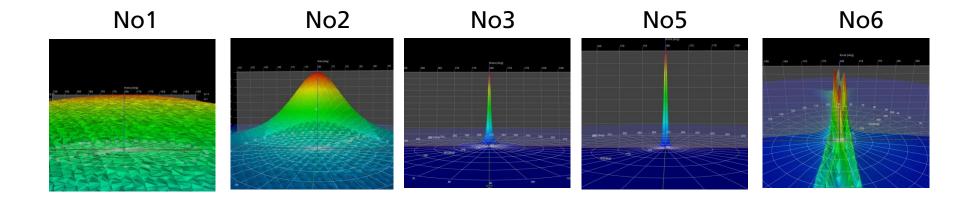


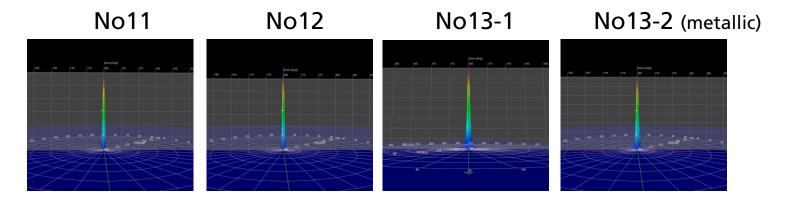


Light source

Investigated solar-shading textiles

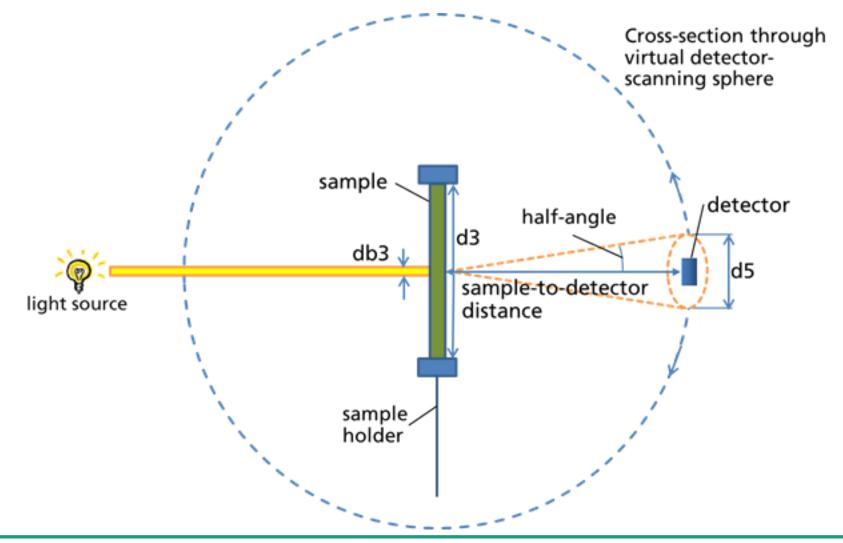
- Photogoniometric transmittance images (BTDF)





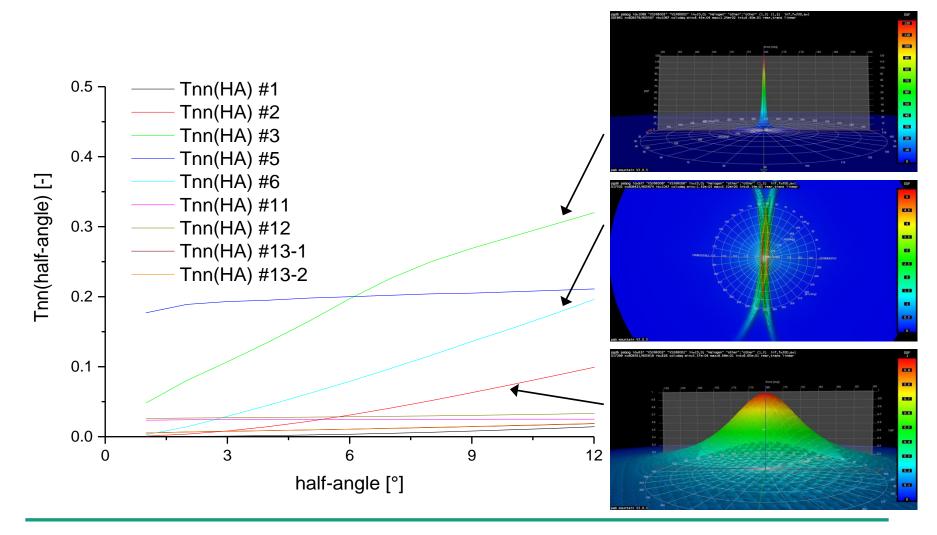


Important parameters for the photogoniometer used for the analysis of the transmitted light

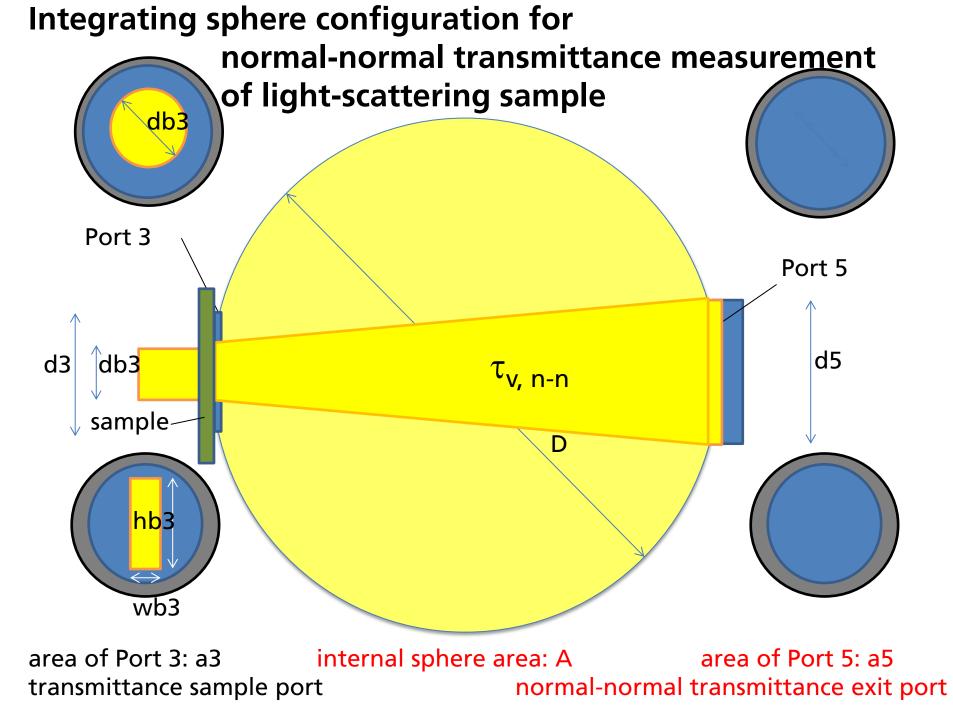




Normal-normal transmittance obtained by integrating photogoniometric data over cap of given half-angle







Determining normal-normal transmittance with an integrating sphere

 $\mathsf{T}_{\mathsf{nn}}(\lambda) = \mathsf{T}_{\mathsf{nh}}(\lambda) - \mathsf{T}_{\mathsf{ndif}}(\lambda),$

where $T_{nh}(\lambda)$ is measured with Port 5 closed with a white plug and $T_{ndif}(\lambda)$ is measured with Port 5 open.

Two hypotheses:

- If the sample at Port 3 is not moved between the $T_{nh}(\lambda)$ and $T_{ndif}(\lambda)$ measurements, $T_{nn}(\lambda)$ can be determined from the equation above even when the $T_{nh}(\lambda)$ and $T_{ndif}(\lambda)$ values themselves are incorrect (errors are identical for both measurements)
- The determined value of $T_{nn}(\lambda)$ depends on a5/A
 - how much depends on the sample scattering distribution



First hypothesis: $T_{nn}(\lambda)$ can be determined from $T_{nn}(\lambda) = T_{nh}(\lambda) - T_{ndif}(\lambda)$

- if sample at Port 3 is not moved between $T_{nh}(\lambda)$ and $T_{ndif}(\lambda)$ measurements
- despite incorrect T_{nh}(λ) and T_{ndif}(λ) values (errors are practically identical for both measurements)

Typical causes of errors in $T_{nh}(\lambda)$ and $T_{ndif}(\lambda)$ determination:

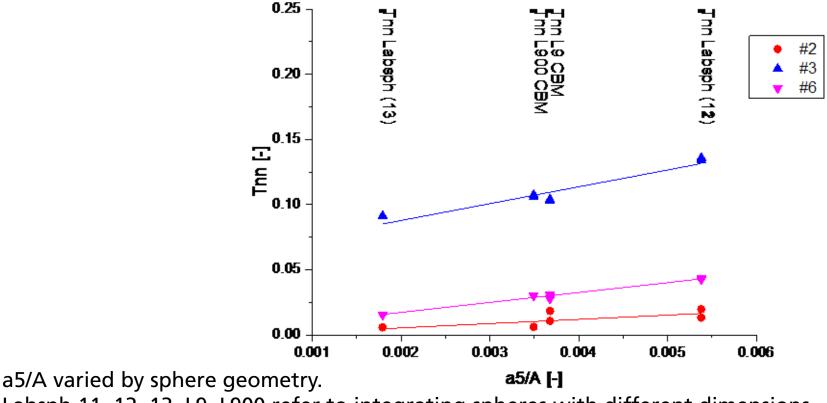
- Losses due to lateral light shift within sample
- Inhomogeneous reflectance of sphere wall (including Port 5 plug)
- Departure from ideal spherical geometry (ports, detectors, baffles
- Detector field of view (assuming this does not include Port 5)



Second hypothesis: T_{nn} (= $T_{nh} - T_{ndif}$) depends on a5/A

T_{v.nn} versus a5/A for three "critical" textile samples (#2, #3, #5):

"Critical" refers to variation of $T_{v,nn}$ value with a5/A



Labsph 11, 12, 13, L9, L900 refer to integrating spheres with different dimensions.

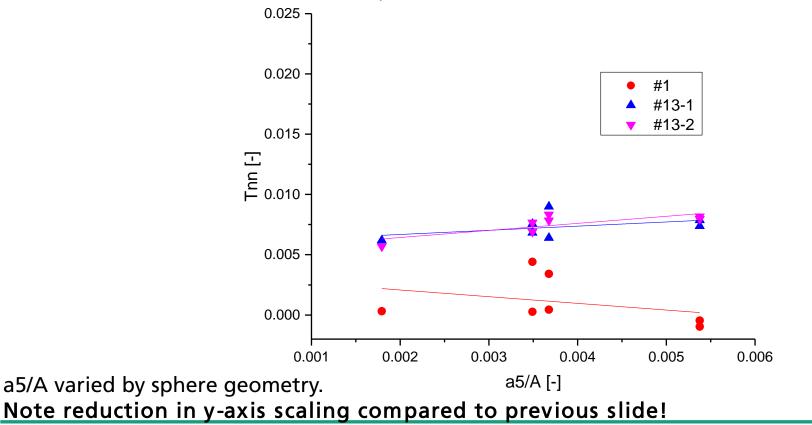


Second hypothesis: T_{nn} (= $T_{nh} - T_{ndif}$) depends on a5/A

- but is significant only for "critical" samples

T_{v,nn} versus a5/A for three "non-critical" textile samples (#1, #13-1, #13-2):

"Critical" refers to variation of $T_{v,nn}$ value with a5/A





Problem

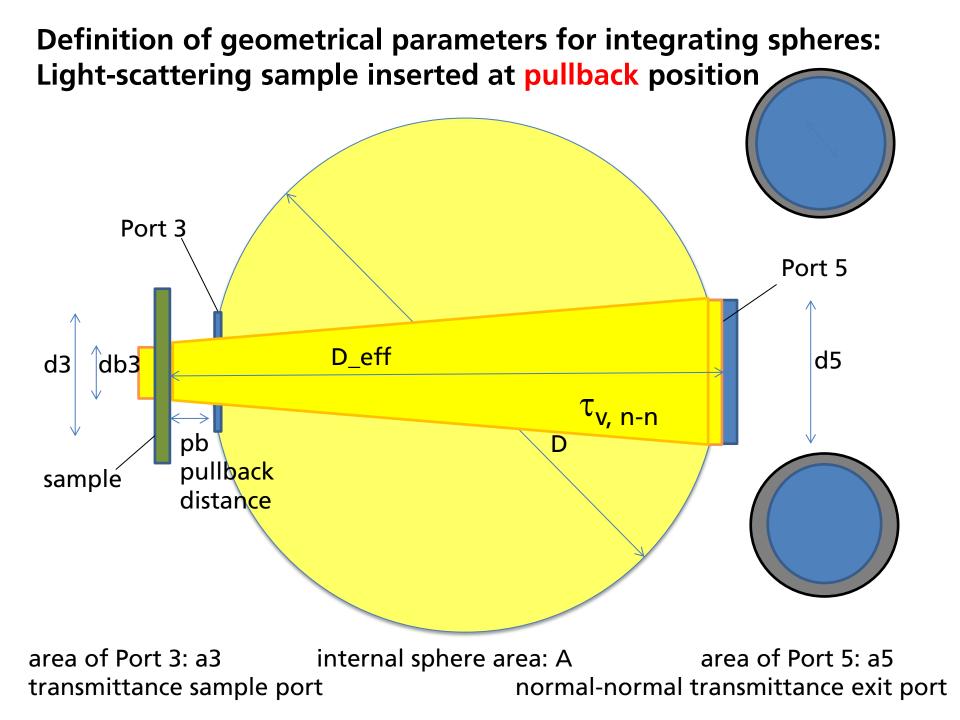
As $T_{nn}(\lambda)$ (= $T_{nh}(\lambda)$ - $T_{ndif}(\lambda)$) depends on a5/A,

how can $T_{nn}(\lambda)$ be determined reproducibly with different integrating spheres?

Solution:

- Limit the allowable range of a5/A (or a5/A_eff: see below)
- Apply the pullback method to measure within this range



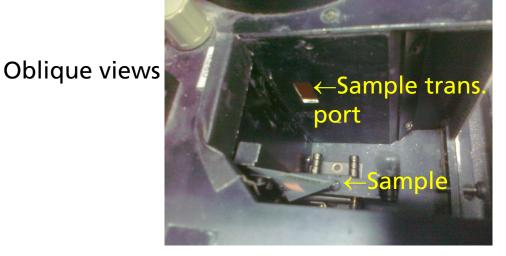


Pullback of sample from transmittance port (port 3)

53 mm pullback

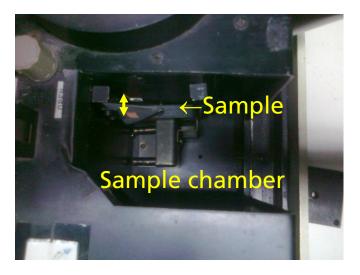
Integrating sphere

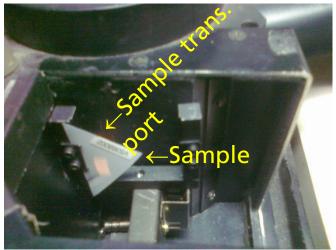
Top views



If pb is the pullback distance, D_eff = D + pb

12 mm pullback





and A_eff = π (D_eff)²

T_{nn} with and without pullback for Screen S2 col S065 white grey (non-critical for T_{nn})

For integrating spheres (220 mm, 150 mm) at Fraunhofer ISE

D [mm]	Pullback [mm]	a5/A or a5/A _{eff}	T _{nh} (pseudo) [-]	T _{ndif} (pseudo) [-]	T _{nn} [-] (550 nm or vis)
220	75	0.00194	0.0380	0.0025	0.0355
220	0	0.00349	0.0788	0.0438	0.0350
150	0	0.00368	0.0774	0.0412	0.0361

Good agreement between T_{nn} results with sample at Port 3 (pullback = 0 mm) and at pullback = 75 mm – despite low $a5/A_{eff}$ value



T_{nn} with and without pullback for Screen S2 col S094 white pearl (non-critical for T_{nn})

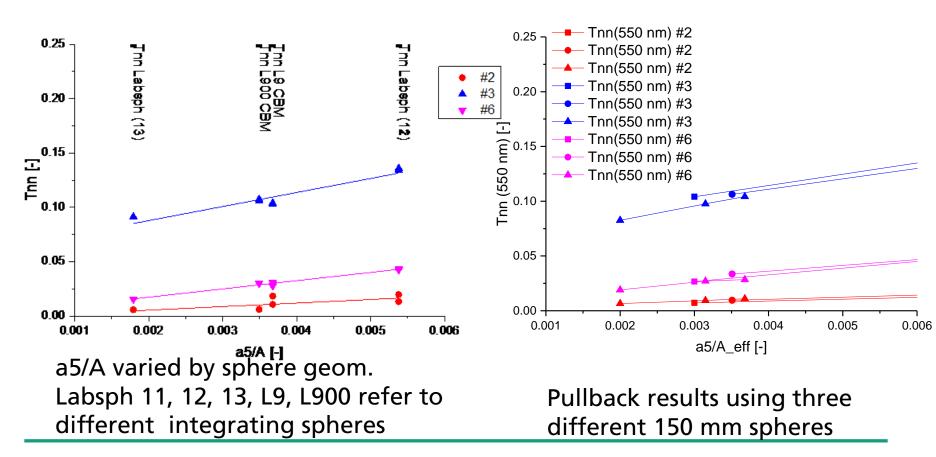
For integrating spheres (220 mm, 150 mm) at Fraunhofer ISE

D [mm]	Pullback [mm]	a5/A or a5/A _{eff}	T _{nh} (pseudo) [-]	T _{ndif} (pseudo) [-]	T _{nn} [-] (550 nm or vis)
220	75	0.00194	0.0380	0.0033	0.0347
220	0	0.00349	0.1094	0.0722	0.0371
150	0	0.00368	0.1087	0.0722	0.0365

Good agreement between T_{nn} results with sample at Port 3 (pullback = 0 mm) and at pullback = 75 mm – despite low $a5/A_{eff}$ value



Comparison for three "critical" textile samples (2, 3, 5) -Dependence of T_{nn} on a5/A or a5/A_eff "Critical" refers to variation of T_{nn} value with a5/A

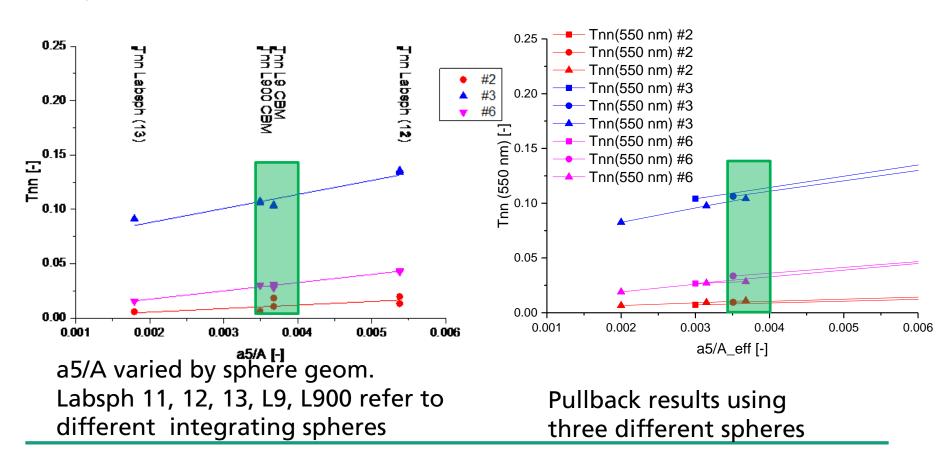




T_{nn}(550 nm) versus a5/A_eff

T_{v.nn} versus a5/A

Comparison for three "critical" textile samples (2, 3, 5) -Dependence of T_{nn} on a5/A or a5/A_eff -> limit allowable values of a5/A or a5/A_eff



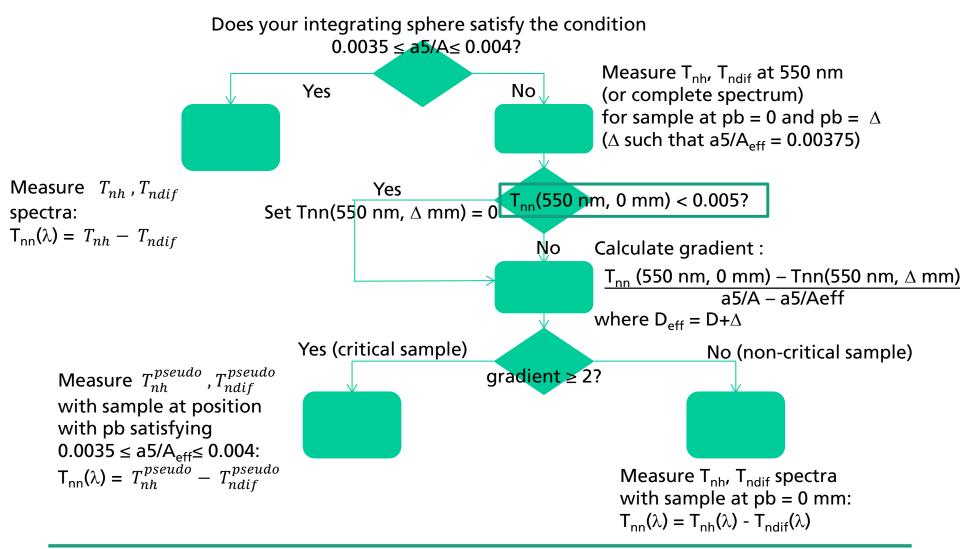


T_{nn}(550 nm) versus a5/A_eff

T_{v.nn} versus a5/A

Revised decision tree for T_{nn} measurements

Def.: T_{nn} of "critical" samples varies significantly with the relative area of port 5



Caution: Special instrumentation may be needed © Fraunhofer ISE to measure the correct values of T_{nh}, T_{ndif}



Conclusions

What does "normal-normal transmittance" mean for light-scattering materials?

- Answer (from EN 14500:2008): Fraction of normally incident radiation flux that is transmitted in accordance with the laws of geometrical optics, without diffusion or redirection
- Answer (if determined using an integrating sphere): $T_{nn}(\lambda) = T_{nh}(\lambda) - T_{ndif}(\lambda)$
 - T_{nn}(λ) is valid, even if T_{nh}(λ) and T_{ndif}(λ) are not, as the main errors cancel out
- As $T_{nn}(\lambda)$ depends on the relative area of the exit port (a5/A or a5/A_eff), the range of this relative area must be restricted to achieve comparability.
- The pullback method is a practicable method to achieve this.

T_{nn}(
$$\lambda$$
) = T^{pseudo}_{nh} - T^{pseudo}_{ndif} in this case.



Outlook

- CEN TC33, WG3, TG5 intends to adopt the approach of restricting the range for a5/A or a5/A_eff and allowing the pullback method to determine T_{nn} in its revision of EN 14500 for solar-shading materials.
- As the approach should be valid for other light-scattering materials, the NFRC Diffuse Glazing TG is also currently considering its adoption.



Supplementary information

For an 150 mm integrating sphere and Port 5 with a diameter of 25 mm:

a5/A _{eff}	pb [mm]	D _{eff}
0.003	78.2	228.2
0.0035	61.3	211.3
0.00375	54.1	204.1
0.004	47.6	197.6
0.0069	0	150

pb = pullback = distance between sample and Port 3 in mm



Thank you for your attention!



Fraunhofer Institute for Solar Energy Systems ISE Helen Rose Wilson www.ise.fraunhofer.de helen.rose.wilson@ise.fraunhofer.de

Acknowledgement

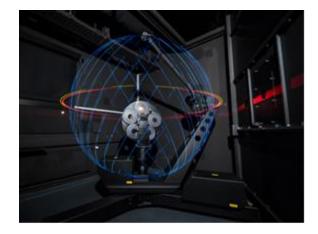
The work reported has been supported by the German Federal Ministry for Economics and Energy within the "Textil-KFFS" project with the funding number 03ET1432A.



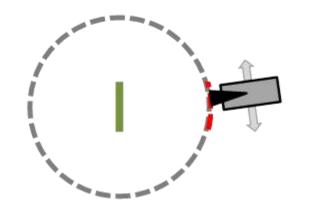
Supplementary slides

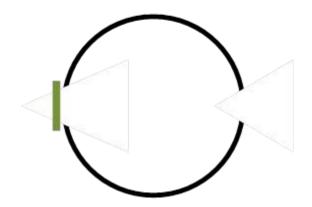


Photogoniometer versus integrating sphere



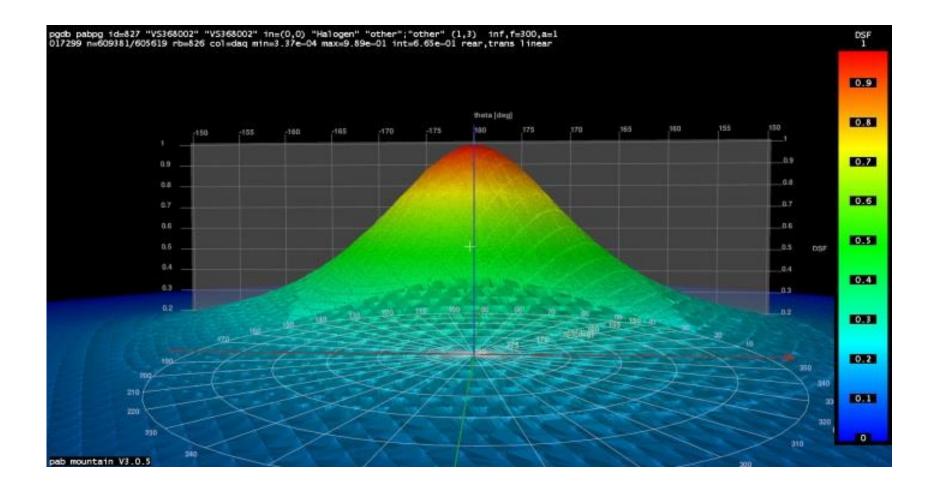






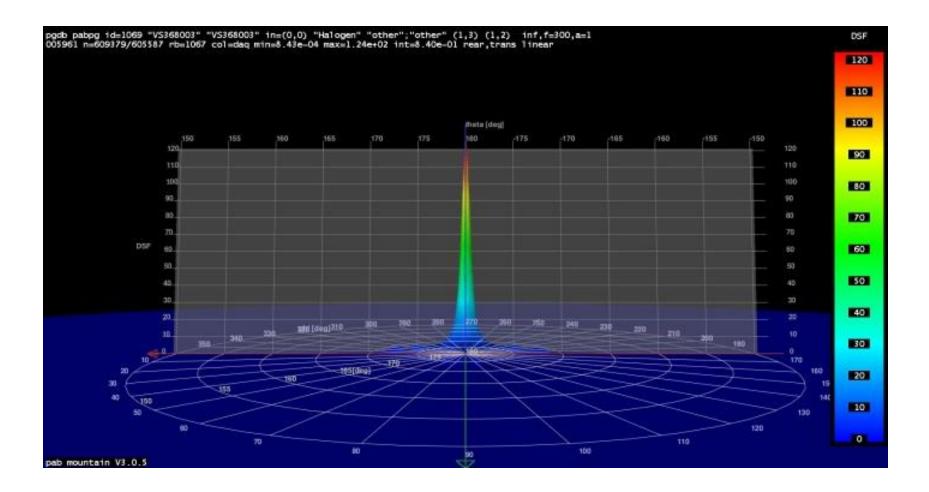


 τ_{n-n} : BDTF of "critical" sample #2



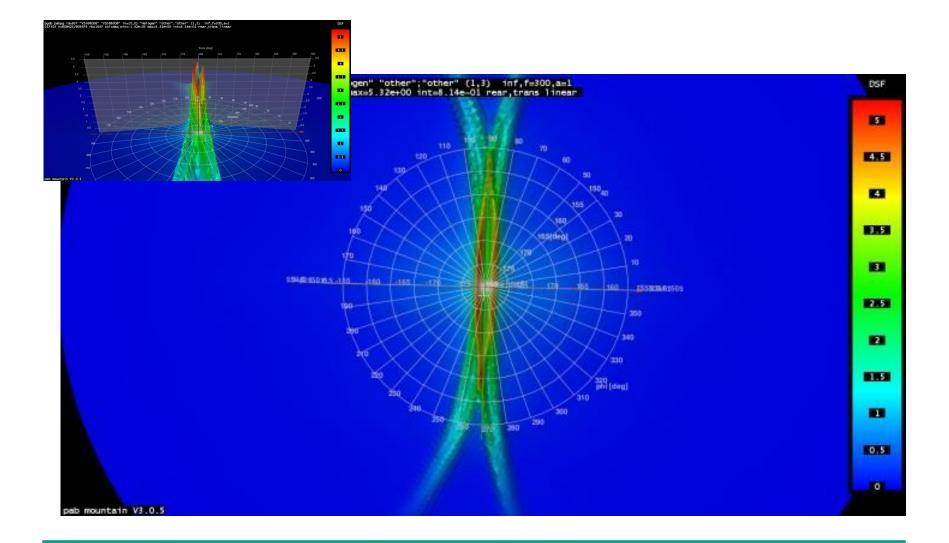


 τ_{n-n} : BDTF of "critical" sample #3



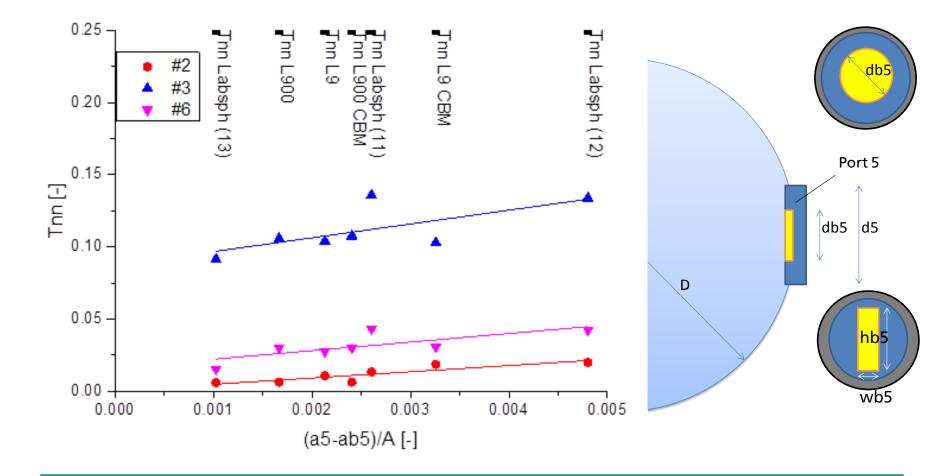


τ_{n-n} : BDTF of "critical" sample #6





τ_{n-n} : Effect of relative areas of port 5 and beam at port 5 Integrating sphere measurements for critical samples 2, 3, 6





 τ_{n-n} : Effect of relative areas of port 5 and beam at port 5 Tnn for all eight samples for three pairs of instruments with identical values of a5/A but different values of (a5 – ab5)/A

